

Ritwik Nag

Ph.D. Student

Department of Electrical Engineering

University of South Carolina, Columbia, SC 29208, USA

(M): +1-803-261-6162

Email: rnat@email.sc.edu || ritwinknag.98@gmail.com

EDUCATION

Ph.D., Department of Electrical Engineering

Expected May 2026

University of South Carolina, Columbia, USA

Advisor: Prof. Krishna C. Mandal

Device Engineering and Defect Characterization of Wide-Bandgap Semiconductor Detectors

M.S., Department of Electrical Engineering

May 2022

University of South Carolina, Columbia, USA

Growth, characterization and evaluation of CdZnTeSe single crystals for room temperature radiation detectors

RESEARCH EXPERIENCE

Graduate Research Assistant (Ph.D.)

August 2022 - Present

Department of Electrical Engineering, University of South Carolina | Columbia, SC 29208, USA

- Growth of crystals using Bridgman and gradient freeze methods. Device fabrication using DC sputtering and surface passivation techniques using chemo-mechanical and growing high-k dielectric layers.
- Experience with device characterizations techniques such as I-V, C-V, SEM-EDX, XPS, and XRD.
- Defect characterization and analysis using deep level transient spectroscopy (DLTS), current transient spectroscopy (CTS) and photo-induced current transient spectroscopy (PICTS) from low (84K) to high temperature (800K).
- Perform data analysis and device modeling using: OriginLab, LTSpice, MATLAB, 1D Poisson Solver, Ansys HFSS, Synopsis Sentaurus, and R-Studio.
- Radiation detection using alpha, beta and gamma sources on fabricated semiconductor devices for testing room temperature and harsh environment applications.

Graduate Research Assistant (M.S.)

Jan 2021 – May 2022

University of South Carolina | Columbia, SC, USA

- Developed and implemented a modified vertical Bridgman method for growing semiconductor single crystals, utilizing in-house zone-refined 7 N purity elemental precursors resulting in enhanced crystal quality.
- Fabricated radiation detectors in planar geometry on CdZnTeSe (CZTS) single crystals using DC Sputtering.
- Crystal characterization using energy-dispersive X-ray (EDX) analysis and powder X-ray diffraction (XRD) ensuring material consistency and reliability.
- Achieved superior charge transport properties in CZTS single crystals by growing detector-grade crystals using the vertical gradient freeze (VGF) method.
- Demonstrated the growth of CZTS single crystals with desired stoichiometry for high resolution radiation detection, laying the groundwork for further advancements in CZTS-based gamma-ray detector technology.

TEACHING EXPERIENCE

Graduate Instructional Assistant University of South Carolina Columbia, SC 29208, USA	Aug 2022 – Dec 2023
- Instructed lab sessions for ELCT 201 (Sophomore): Introduction to Electrical Circuits, impacting about 200 undergraduate students. - Developed and implemented lab frameworks, improving student engagement.	

Grader/Teaching Assistant University of South Carolina Columbia, SC 29208, USA	Jan 2024 – May 2025
- ELCT 363: Introduction to Microelectronics (Undergraduate Course) - ELCT 510: Photovoltaics Materials and Devices (Undergraduate and Graduate students combined course)	

HONORS, AWARDS, GRANTS & SCHOLARSHIPS

SPARC Graduate Research Grant, Office of Vice President (VP) Research, USC, 2024: High-resolution brain imaging system based on multi-pixel CdZnTeSe detector.

Travel Grant, Graduate School, University of South Carolina, 2024.

Best Student Poster Award, IEEE-NSS/MIC/RTSD, Tampa, Florida, USA, 11/2/ 2024.

SERVICE ACTIVITIES

Lab Safety Officer, Photovoltaics and Radiation Detectors (PANRAD) Lab, USC, Columbia. 2021 – Present

- Maintenance of research laboratories and training new research students in lab safety protocols.
- Keeping up compliance with Environment, Health, and Safety (EHS) regulations and helping conduct monthly, quarterly and annual lab safety checks with USC and EHS.

IEEE Graduate Student Member 2021 - Present

Journal Reviewer 2022 – Present

- Energy Reports, Elsevier
- Microelectronics, Elsevier
- Nuclear Engineering and Technology, Elsevier
- Nuclear Instruments & Methods in Physics Research, Elsevier

JOURNAL PUBLICATIONS

1. **Nag, Ritwik;** Oner, Cihan; Chaudhuri, Sandeep K; Mandal, Krishna C; “Investigating 4H-SiC epilayer thickness variation in high-resolution Ni/Y₂O₃/4H-SiC MOS detectors,” **Journal of Materials Science: Materials in Electronics**, **36**, 34, 2172, 2025, DOI: <https://doi.org/10.1007/s10854-025-16272-y>
2. **Nag, Ritwik;** Chaudhuri, Sandeep K; Ruddy, Frank H; Mandal, Krishna C; “High-

Resolution Cr/4H-SiC Schottky Barrier Radiation Detector," IEEE Transactions on Nuclear Science, 72, 4, 1644-1651, 2025, DOI: [10.1109/TNS.2025.3547998](https://doi.org/10.1109/TNS.2025.3547998)

3. **Nag, Ritwik;** Chaudhuri, Sandeep K; Kleppinger, Joshua W; Karadavut, OmerFaruk; Mandal, Krishna C.; “*Vertical gradient freeze growth of detector grade CdZnTeSe single crystals,*” **Journal of Crystal Growth**, **596**, 126826-1-7, 2022, DOI: <https://doi.org/10.1016/j.jcrysgro.2022.126826>
4. **Nag, Ritwik;** Chaudhuri, Sandeep K; Kleppinger, Joshua W; Karadavut, OmerFaruk; Mandal, Krishna C; “*Characterization of vertical Bridgman grown Cd_{0.9}Zn_{0.1}Te_{0.97}Se_{0.03} single crystal for room-temperature radiation detection,*” **Journal of Materials Science: Materials in Electronics**, **32**, 26740-26749, 2021, DOI: <https://doi.org/10.1007/s10854-021-07051-6> (Editor’s choice and featured in the cover page of the journal)
5. Mandal, Krishna C; Oner, Cihan; Chaudhuri, Sandeep K; **Nag, Ritwik;** “*Metal-free (p+) diamond/(n)4H-SiC epitaxial Heterojunction Diodes for Radiovoltaic Applications,*” **IEEE Electron Device Letters – Accepted, in press;** DOI: <https://doi.org/10.1109/LED.2025.3640092>
6. Chaudhuri, Sandeep K; **Nag, Ritwik;** Roy, Utpal N, James, Ralph B Mandal, Krishna C; “*Determination of electron-hole pair creation energy in Cd_{0.9}Zn_{0.1}Te_{0.98}Se_{0.02} quaternary semiconductor for room-temperature gamma-ray detection,*” **Electronics Letters**, **60**, 17, 2024, DOI: <https://doi.org/10.1049/ell2.70007>
7. Chaudhuri, Sandeep K; **Nag, Ritwik;** Roy, Utpal N, James, Ralph B; Mandal, Krishna C; “*High-Resolution γ -Ray Spectroscopy in Capacitive Frisch Grid CdZnTeSe Detectors,*” **IEEE Electron Device Letters**, **45**, 10, 1702-1705, 2024, DOI: [10.1109/LED.2024.3437230](https://doi.org/10.1109/LED.2024.3437230)
8. Chaudhuri, Sandeep K; **Nag, Ritwik;** Ahmad, Iftikhar, Mandal, Krishna C; “*Alpha Particle Detection Using Highly Rectifying Ni/Ga₂O₃/4H-SiC Heteroepitaxial MOS Junction,*” **IEEE Transactions on Electron Devices**, **70**, 12, 6439-6445, 2023, DOI: [10.1109/TED.2023.3328329](https://doi.org/10.1109/TED.2023.3328329)
9. Chaudhuri, Sandeep K; **Nag, Ritwik;** Kleppinger, Joshua W; Roy, Utpal N; James, Ralph B; Mandal, Krishna C; “*Charge Trapping Effects in THM-and VGF-Grown CdZnTeSe Radiation Detectors,*” **IEEE Transactions on Nuclear Science**, **70**, 9, 2256-2263, 2023, DOI: [10.1109/TNS.2023.3306283](https://doi.org/10.1109/TNS.2023.3306283)
10. Kleppinger, Joshua W; Chaudhuri, Sandeep K; **Nag, Ritwik;** Roy, Utpal N; James, Ralph B; Mandal, Krishna C; “*Assessment of deep levels with selenium concentration in Cd_{1-x}Zn_xTe_{1-y}Se_y room temperature detector materials,*” **Applied Physics Letters**, **123**, 6, 2023, DOI: <https://doi.org/10.1063/5.0159519>
11. Mandal, Krishna C; Chaudhuri, Sandeep K; **Nag, Ritwik;** “*High Performance Pd/4H-SiC Epitaxial Schottky Barrier Radiation Detectors for Harsh Environment Applications,*” **Micromachines**, **14**, 8, 1532, 2023, DOI: <https://doi.org/10.3390/mi14081532>

12. Chaudhuri, Sandeep K; **Nag, Ritwik**; Mandal, Krishna C; “*Self-biased Mo/n-4H-SiC Schottky barriers as high-performance ultraviolet photodetectors,*” **IEEE Electron Device Letters**, **44**, 5, 733-736, 2023, DOI: [10.1109/LED.2023.3256344](https://doi.org/10.1109/LED.2023.3256344)
13. Chaudhuri, Sandeep K; **Nag, Ritwik**; Mandal, Krishna C; “*A novel Ni/Y₂O₃/4H-SiC heteroepitaxial metal–oxide–semiconductor (MOS) betavoltaic cell,*” **Journal of Materials Science: Materials in Electronics**, **34**, 6, 543, 2023, DOI: <https://doi.org/10.1007/s10854-023-09971-x>
14. Chaudhuri, Sandeep K; **Nag, Ritwik**; Kleppinger, Joshua W; Mandal, Krishna C; “*Investigation of Charge Transport Properties and the Role of Point Defects in CdZnTeSe Room Temperature Radiation Detectors,*” **High-Z Materials for X-ray Detection: Material Properties and Characterization Techniques**, 171-188, 2023, Springer International Publishing Cham, DOI: https://doi.org/10.1007/978-3-031-20955-0_9
15. Chaudhuri, Sandeep K; Karadavut, OmerFaruk; Kleppinger, Joshua W; **Nag, Ritwik**; Yang, Gene; Lee, Dongkyu; Mandal, Krishna C; “*Enhanced Hole Transport in Ni/Y₂O₃/n-4H-SiC MOS for Self-Biased Radiation Detection,*” **IEEE Electron Device Letters**, **43**, 9, 1416-1419, 2022, DOI: <https://doi.org/10.1109/LED.2022.3188543>
16. Karadavut, OmerFaruk; Chaudhuri, Sandeep K; Kleppinger, Joshua W; **Nag, Ritwik**; Mandal, Krishna C; “*Enhancement of radiation detection performance with reduction of EH_{6/7} deep levels in n-type 4H–SiC through thermal oxidation,*” **Applied Physics Letters**, **121**, 1-7, 2022, DOI: <https://doi.org/10.1063/5.0089236>
17. Kleppinger, Joshua W; Chaudhuri, Sandeep K; Karadavut, Omerfaruk; **Nag, Ritwik**; Watson, Daniel LP; McGregor, Douglas S; Mandal, Krishna C; “*Deep-level transient spectroscopy and radiation detection performance studies on neutron irradiated 250-μm-thick 4H-SiC epitaxial layers,*” **IEEE Transactions on Nuclear Science**, **69**, 8, 1972-1978, 2022, DOI: <https://doi.org/10.1109/TNS.2022.3168789>
18. Karadavut, Omerfaruk; Chaudhuri, Sandeep K; Kleppinger, Joshua W; **Nag, Ritwik**; Mandal, Krishna C; “*Performance-Improved Vertical Ni/SiO₂/4H-SiC Metal–Oxide–Semiconductor Capacitors for High-Resolution Radiation Detection,*” **IEEE Transactions on Nuclear Science**, **69**, 8, 1965-1971, 2022, DOI: <https://doi.org/10.1109/TNS.2022.3168792>
19. Kleppinger, Joshua W; Chaudhuri, Sandeep K; Karadavut, OmerFaruk; **Nag, Ritwik**; Mandal, Krishna C; “*Influence of carrier trapping on radiation detection properties in CVD grown 4H-SiC epitaxial layers with varying thickness up to 250 μm,*” **Journal of Crystal Growth**, **583**, 126532, 2022, DOI : <https://doi.org/10.1016/j.jcrysgro.2022.126532>
20. Chaudhuri, Sandeep K; Kleppinger, Joshua W; Karadavut, OmerFaruk; **Nag, Ritwik**; Panta, Rojina; Agostinelli, Forest; Sheth, Amit; Roy, Utpal N; James, Ralph B; Mandal, Krishna C; “*Synthesis of CdZnTeSe single crystals for room temperature radiation detector fabrication: mitigation of hole trapping effects using a convolutional neural network,*” **Journal of Materials Science: Materials in Electronics**, **33**, 3, 1452-1463, 2022, DOI: <https://doi.org/10.1007/s10854-021-07623-6>
21. Karadavut, OmerFaruk; Chaudhuri, Sandeep K; Kleppinger, Joshua W; **Nag, Ritwik**; Mandal, Krishna C; “*Effect of oxide layer growth conditions on radiation detection performance of Ni/SiO₂/epi-4H-SiC MOS capacitors,*” **Journal of Crystal Growth**, **584**, 126566, 2022, DOI: <https://doi.org/10.1016/j.jcrysgro.2022.126566>

22. Chaudhuri, Sandeep K; Kleppinger, Joshua W; Karadavut, OmerFaruk; **Nag, Ritwik**; Mandal, Krishna C; “*Quaternary semiconductor Cd_{1-x}Zn_xTe_{1-y}Se_y for high-resolution, room-temperature gamma-ray detection,*” **Crystals**, **11**, 7, 827, 2021, DOI: <https://doi.org/10.3390/crust11070827>

CONFERENCE and POSTER PRESENTATION

1. **Nag, Ritwik**; Stefurak, Jarod; Chaudhuri, Sandeep K; Mandal, Krishna C; “*High-resolution real-time brain imaging system using novel CdZnTeSe semiconductor detector arrays,*” **Discover USC, 2025, April, Columbia, USA – Poster Presentation.**
2. **Nag, Ritwik**; Chaudhuri, Sandeep K; Mandal, Krishna C; “*Radiation Detection with Vertical Gradient Freeze Grown CdZnTeSe Crystals,*” **IEEE-NSS/MIC/RTSD, 2024, November, Tampa, Florida, USA – Poster Presentation – Winner of Best Poster Award.**
3. **Nag, Ritwik**; Chaudhuri, Sandeep K; Mandal, Krishna C; Ruddy, Frank H; “*High Resolution Cr/4H-SiC Radiation Detector for Harsh Environment Applications,*” **IEEE-NSS/MIC/RTSD, 2024, Tampa, Florida, November USA.**
4. Mandal, Krishna C; Chaudhuri, Sandeep K; **Nag, Ritwik**; Valdebran, Manual C; “*High Responsivity (p+)diamond/(n)4H-SiC Schottky Barrier Radiation Detectors,*” **IEEE-NSS/MIC/RTSD, 2024, November, Tampa, Florida, USA.**
5. **Nag, Ritwik**; Chaudhuri, Sandeep K; Mandal, Krishna C; “*Correlation of transport properties with charge trapping parameters in Cd_{0.9}Zn_{0.1}Te_{1-x}Se_x room temperature gamma-ray detectors,*” **SPIE Optical Engineering + Applications, 2023, San Diego, California, USA.**
6. Karadavut, OmerFaruk; **Nag, Ritwik**; Kleppinger, Joshua W; Yang, Gene; Lee, Dongkyu; Chaudhuri, Sandeep K; Mandal, Krishna C; “*Investigation of Ni/Y₂O₃/n-4H-SiC metal-oxide-semiconductor structure for high-resolution radiation detection,*” **SPIE Optical Engineering + Applications, 2022, San Diego, California, USA.**
7. Karadavut, OmerFaruk; Kleppinger, Joshua W; **Nag, Ritwik**; Chaudhuri, Sandeep K; Mandal, Krishna C; “*Observation of minority carrier traps using C-DLTS in Au/SiO₂/n-4H-SiC vertical MOS capacitor,*” **SPIE Optical Engineering + Applications, 2021, San Diego, California, USA.**
8. Kleppinger, Joshua W; Karadavut, OmerFaruk; **Nag, Ritwik**; Chaudhuri, Sandeep K; Mandal, Krishna C; “*High-resolution 4H-SiC Schottky barrier radiation detectors on 250 μm epitaxial layers for harsh environment applications,*” **SPIE Optical Engineering + Applications, 2021, San Diego, California, USA.**
9. Chaudhuri, Sandeep K; Kleppinger, Joshua W; **Nag, Ritwik**; Roy, Kaushik; Panta, Rojina; Agostinelli, Forest; Sheth, Amit; Roy, Utpal N; James, Ralph B; Mandal, Krishna C; “*A CdZnTeSe gamma spectrometer trained by deep convolutional neural network for radioisotope identification,*” **SPIE Optical Engineering + Applications, 2021, San Diego, California, USA.**